


<b>Search Notes</b>  	<b>Application/Control No.</b>  10523070	<b>Applicant(s)/Patent Under Reexamination</b>  YAGI ET AL.
	<b>Examiner</b>  SHENG HAN	<b>Art Unit</b>  4162

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East search in UP Pats, US PG Pub, USOCR, EPO, JPO and Derwent	9/24/2008	SH
Internet search	9/24/2008	SH
Updated East search	11/5/2009	SH
Consulted with Matthew Merkling	11/5/2009	SH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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